

14. TEST SETUP PHOTOGRAPHS

FCC ID: A3LSMJ320VPP		HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename: 0Y1601280172-R2.A3L	Test Dates: 02/17/2016	EUT Type: Portable Handset	Page 54 of 56	

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Figure 14-1
Test Setup for Wireless Device

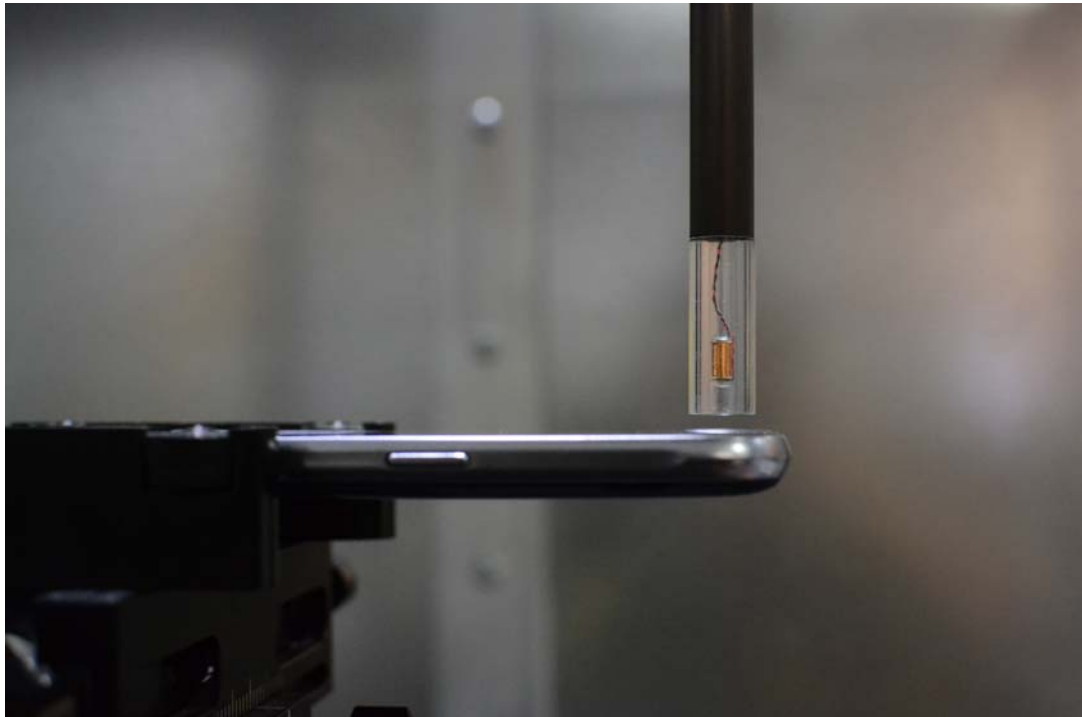


Figure 14-2
Test Setup for Wireless Device

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Figure 14-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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